

# Ultrafast All-Optical Switching via Subdiffractional Photonic Nanojets and Select Semiconductor Nanoparticles

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**ABSTRACT:** Nanophotonic all-optical switching is anticipated to replace electronic processing in future optical fiber front-end systems, unlocking capabilities for all-optical terabit-per-second processing. This work introduces a new all-optical switch (AOS) as a fundamental element for such processing. The AOS applies a nanophotonic superlens, in the form of a dielectric microsphere, to form an intense nonevanescent subdiffractional focus called a photonic nanojet. The photonic nanoparticles at the rear of the microsphere. The AOS is refined



using Lorenz–Mie theory simulations and free-carrier dynamical modeling. Experiments with microspheres coated by Si, CdTe, InP, and CuO nanoparticles, having radii of 40, 30, 20, and 20 nm, reveal switching energies of 1 pJ, 500 fJ, 400 fJ, and 300 fJ and switching times of 2 ps, 2.3 ps, 900 fs, and 350 fs, respectively. The realized AOS meets the ultimate goals of femtojoule switching energies and femtosecond switching times.

KEYWORDS: nanophotonics, all-optical switching, femtosecond optics, photonics nanojet, semiconductor nanoparticles

**F** iber-optic technology has witnessed exponential growth in demand due to its unrivaled data transmission speeds. However, a bandwidth bottleneck<sup>1</sup> limits these high-speed (terabit-per-second) optical links due to a reliance on far slower (gigabit-per-second) processing by electronic transmitters and receivers. All-optical systems have been proposed to alleviate this bottleneck, and the all-optical switch (AOS) is the fundamental building block of such systems.<sup>2,3</sup> All-optical switching can ultimately enable terabit-per-second processing in optical fiber front-end systems, in the form of optical time-division multiplexers (OTDM),<sup>4</sup> orthogonal frequency-division multiplexers (OFDM),<sup>5</sup> or even network-on-a-chip systems.<sup>6,7</sup>

Nanotechnology has emerged as a key technology to meet the demands of all-optical switching. Nanoscale AOS devices can operate with femtosecond switching times to enable terabitper-second data rates, and they can operate with femtojoule switching energies to enable future all-optical networks.<sup>8–11</sup> The demands for switching speed and energy must both be met in a practical AOS implementation, however, and these demands are often mutually exclusive.<sup>12–14</sup> To develop an AOS that meets both these demands, it is necessary to establish especially strong and rapid interactions between the coincident control (pump) beam and signal (probe) beam.

The onset of the control pulse must initiate strong nonlinear interaction between the control and signal beams to facilitate operation with femtojoule switching energies. As the strength of the interaction is proportional to the intensities, concentrating the beams within a high-intensity focal spot is desirable. Thus, this study introduces a nanophotonic superlens, in the form of a dielectric microsphere, to achieve an intense nonevanescent subdiffractional focus called a photonic nanojet.  $^{15-17}$  The microsphere's diameter and refractive index are optimized in this work to maximize the intensity of the photonic nanojet.

The termination of the control pulse must then be followed by rapid recovery of the all-optical switching medium to facilitate operation with femtosecond switching times. With this in mind, we have recently shown that the recovery times can be reduced to femtosecond time scales by using semiconductor nanostructures as the all-optical switching medium.<sup>18,19</sup> The reduced recovery times, which can be as much as 6 orders of magnitude lower than those of the bulk semiconductors, result from the prevalence of surface states within the nanostructures. In this study, the semiconductor nanostructures are implemented in the form of semiconductor nanoparticles, of varying compositions. The semiconductor nanoparticles are embedded onto the surface of the aforementioned microsphere. This has the intense focus of the photonic nanojet materialize within the semiconductor nanoparticles.

It is shown that the proposed AOS with integrated photonic nanojets and semiconductor nanoparticles can enable both femtojoule switching energies and femtosecond switching times, with omnidirectional operation, a small device footprint, and an integrated focusing element. Theoretical models are developed to characterize responses of the photonic nanojets and nanoparticles. Experimental results are presented from tests

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of the developed AOS with semiconductor nanoparticles having varying compositions.

The first point of consideration in this work is the implementation of a nanophotonic superlens with a maximized intensity for its photonic nanojet. An appropriately designed microsphere can establish such a response by refracting incident light at its front surface to an intense focus on its rear surface. The resulting protrusion of intense optical power at and beyond the microsphere's rear surface is referred to as a photonic nanojet. For the purposes of this work, the specific characteristics of a photonic nanojet are defined by the presence of a subwavelength full-width-at-half-maximum (fwhm) and a micrometer-scale propagation distance.<sup>20</sup> (It should also be noted that alternative definitions<sup>21</sup> do exist.) The small focal spot of the photonic nanojet leads to exceedingly high intensities for the interacting control and signal beams, and this can be exploited for reduced switching energies in all-optical applications. The properties of the microsphere must be chosen carefully to attain the ideal characteristics of the photonic nanojet, however, as there exists a complex relationship between the photonic nanojet's intensity and the microsphere's refractive index, n, and diameter, d. For this work, the refractive index is defined within the range  $1.5 \leq$  $n \leq 2.0$ , for realization with contemporary glasses, and the corresponding range of diameters is determined to bring about intense focusing on the microsphere's rear surface. For large spheres, conforming to the thick lens formula, it is known that the highest refractive index in this range,  $n \approx 2.0$ , focuses incident light rays on the microsphere's rear surface.<sup>22</sup> For smaller spheres, it becomes necessary to carry out threedimensional electromagnetic analyses, by way of Lorenz-Mie theory simulations,<sup>17</sup> to define the precise conditions for highintensity focusing on the microsphere's rear surface.

The results from the Lorenz–Mie theory simulations are shown in Figure 1. The figure shows curves for the intensity at the microsphere's rear surface as a function of its refractive



**Figure 1.** Characterization of photonic nanojet intensities formed by microspheres. Normalized intensity at the microsphere's rear surface is shown versus the microsphere's refractive index, *n*, for microsphere diameters of  $d = 20 \ \mu\text{m}$  (purple),  $30 \ \mu\text{m}$  (green),  $40 \ \mu\text{m}$  (black), and  $50 \ \mu\text{m}$  (red). Peak intensities are at n = 1.80, 1.82, 1.83, and 1.86, respectively. Insets a, b, and c show the intensity at the microsphere's rear surface for  $d = 40 \ \mu\text{m}$  and n = 1.66, 1.83, and 2.00, respectively. The results are generated from Lorenz–Mie theory simulations at a wavelength of 775 nm. The scale bar is  $1 \ \mu\text{m}$ .

index, *n*. Each data point on the curves is an individual Lorenz– Mie solution. The four displayed curves correspond to microsphere diameters of d = 20, 30, 40, and 50  $\mu$ m. Microspheres with diameters below these values are neglected, as there is a desire to avoid resonances within the structure, which come about via longitudinal and/or whispering gallery modes.<sup>23</sup> The mitigation of such resonances diminishes the effects of cavity lifetimes and enables more rapid all-optical switching times.

It is readily apparent from Figure 1 that microspheres of differing diameters have optimal (peak) intensities at differing refractive indices. For microsphere diameters of d = 20, 30, 40,and 50  $\mu$ m, peak intensities are achieved at the microsphere's rear surface for refractive indices of n = 1.80, 1.82, 1.83, and1.86, respectively. It is seen here that greater refraction is needed for microspheres of increasing diameters, and this is a result of the interplay between paraxial and nonparaxial focusing. The paraxial region of the beam forms a focal plane farther from the microsphere's center, in comparison to that formed by the nonparaxial region of the beam. Thus, for the desired focusing at the microsphere's rear surface, a largediameter sphere with a large paraxial region requires a high refractive index, while a small-diameter sphere with a smaller paraxial region requires a low refractive index. In the limiting case of increasing sphere diameters, the refractive index that is required for focusing at the microsphere's rear surface is the geometrical-optics limit of  $n \approx 2.0$ . For the implementation in this study, a microsphere diameter of  $d = 40 \ \mu m$  is chosen, as its intensity peaks at the refractive index of N-LASF9 glass, n =1.83. The photonic nanojet intensity for this microsphere diameter is displayed as the solid black curve in Figure 1.

The intensity profiles at the microsphere's rear surface are shown as insets in Figure 1 for an incident wavelength of 775 nm. Inset 1a shows the intensity profile for a refractive index of n = 1.66. This relatively low refractive index leads to focusing beyond the microsphere and a low intensity at the microsphere's rear surface. Inset 1b shows the intensity profile for a refractive index of n = 1.83. Inset 1c shows the intensity profile for a refractive index of n = 2.00. This relatively high refractive index leads to focusing within the microsphere and a low intensity at the microsphere's rear surface. It can be concluded that a microsphere with a diameter of  $d = 40 \ \mu m$  and refractive index of n = 1.83 is optimal for the formation of a nanophotonic superlens with a high-intensity photonic nanojet. This refractive index leads to pronounced focusing, with a subwavelength fwhm of 540 nm, being transverse to the optical axis at the microsphere's rear surface, and with a micrometerscale propagation distance of 1.68  $\mu$ m, being the distance along the optical axis over which the beam remains subwavelength. Such characteristics meet the defining criteria for a photonic nanojet.20

The second point of consideration in this work is the implementation of semiconductor nanoparticles. The composition and size of the semiconductor nanoparticles must both be considered.

The semiconductor composition is selected with consideration of the nonlinear interaction between the control and signal beams. It is necessary to establish pronounced nonlinear interaction over the micrometer-scale length of the photonic nanojet, to enable femtojoule switching energies, and this can be achieved only by having a sufficiently strong nonlinearity. With this in mind, semiconductor nanoparticles exhibiting resonant third-order (Kerr) nonlinearities are applied here to mediate interactions between the control (pump) beam at 775 nm and signal (probe) beam at 1550 nm. This allows the above-band-gap control beam to induce free carriers and modulate the below-band-gap signal beam over sufficiently short propagation lengths. (Resonant third-order nonlinear coefficients are orders of magnitude higher than their nonresonant counterparts, so the need for phase-matched propagation over millimeter or centimeter lengths<sup>3</sup> is avoided.) In summary, resonant nonlinearity, in the semiconductor nanoparticles, is the means by which the control beam optically switches the signal beam, via free-carrier generation.<sup>24</sup> The use of resonant nonlinearity, however, leads to an additional constraint, in that the free-carrier lifetime must be made sufficiently short to enable femtosecond switching times.

The nanoparticle size is selected with consideration of surface recombination and its effect on the free-carrier lifetime. Surface recombination comes about through the existence of trapping sites that promote electron—hole recombination. Our prior all-optical switching work has shown that semiconductors in the form of cylindrical nanostructures (photonic crystals)<sup>18</sup> and spherical nanostructures (nanoparticles)<sup>25</sup> have especially high surface-state densities, and this can lead to rapid surface-assisted recombination and femtosecond switching times.

The nature of the control-signal beam interaction in the semiconductor nanoparticles is revealed by considering the effects of control-beam-induced free carriers and state filling on the signal beam. The above-band-gap control beam introduces a free-carrier density, N(t), which decreases the refractive index at the surface (free-carrier dispersion) and increases the absorption in the bulk (free-carrier absorption).<sup>26</sup> In accordance with Drude theory, these respective responses lead to competing increases and decreases in the signal beam's transmission. Semiconductor nanoparticles do not typically exhibit this competitive response, however, as their scale is far smaller than the optical penetration depth, and so surface effects dominate. Thus, nanoparticles predominantly exhibit an increasing signal beam transmission due to free-carrier dispersion.<sup>27</sup> (It should be noted that the radius of nanoparticles must be well above the Bohr exciton radius to be able to ignore quantum confinement effects, as is the case in this study.) State filling must also be considered, given that the large surface area of the nanostructures introduces midgap surface states within the band structure. Thus, the free carriers induced by the control beam can occupy midgap surface states and impede the signal beam absorption (occurring to and from these midgap surface states).<sup>28,29</sup> In this study, the differential transmission of the signal beam,  $\Delta T(t)/T$ , is measured and is seen to be subject to effects of free carriers and state filling, with each of these contributions being proportional to the freecarrier density, N(t), within the semiconductor nanoparticles.<sup>30</sup>

A free-carrier dynamical model is formed to develop an understanding of the optical response for a semiconductor nanoparticle. The free-carrier density distribution,  $N(r, \theta, t)$ , evolves along the radial dimension, r, with the polar angle,  $\theta$ , through time, t. The uniformly illuminated nanoparticles have an initial free-carrier density of  $N_0$ , with these free carriers undergoing diffusion and recombination in accordance with

$$\frac{\partial N(r,\,\theta,\,t)}{\partial t} = N_0 \delta(t) + D\nabla^2 N(r,\,\theta,\,t) - \frac{N(r,\,\theta,\,t)}{\tau_{\rm b}}$$
(1)

where the free-carrier photogeneration is quantified by the delta function  $\delta(t)$ , diffusion is defined by the diffusion coefficient, *D*,

and bulk recombination is defined by the bulk recombination lifetime,  $\tau_{\rm b}$ . The diffusing free carriers ultimately reach the radius, *a*, and undergo surface recombination in accordance with the boundary condition  $-D\partial N(r = a, \theta, t)/\partial r = S_{\rm v}N(r = a, \theta, t)$ , where the surface recombination velocity is  $S_{\rm v}$ . Once the free-carrier density distribution,  $N(r, \theta, t)$ , is found, it can be averaged to form the free-carrier density, N(t), and differential transmission of the signal beam,  $\Delta T(t)/T$ .

For direct solutions to eq 1, a frequency-domain (Laplace) approach can be applied. The Laplace solution, N(r,s), is formed, given the independence from the polar angle,  $\theta$ , and its inverse Laplace transform is computed according to

$$N(r, t) = \mathcal{L}^{-1}\{N(r, s)\} = \mathcal{L}^{-1}\left\{\frac{N_0}{s + 1/\tau_b} \times \left[1 - \frac{a}{r} \frac{S_v \sinh(kr)}{(S_v - D/a)\sinh(ka) + Dk\cosh(ka)}\right]\right\}$$
(2)

where  $k = \sqrt{s/D + 1/\tau_b}$ . Given the complexity of eq 2, a numerical routine is used to compute the inverse Laplace transform, N(r, t), for varying values of the parameters *a*, *D*, and  $S_v$ .

For a physical understanding of the solutions to eq 1, a timedomain approach can be applied instead. The differential form of eq 1 yields a general solution that varies with the radial dimension, *r*, polar angle,  $\theta$ , and time, *t*. The general solution is<sup>31</sup>

$$N(r, \theta, t) = \sum_{m=0}^{\infty} \sum_{i=1}^{\infty} \Gamma_{m,i} j_{m}(\lambda_{m,i}r/a) P_{m}(\cos \theta) e^{-t/\tau_{m,i}}$$
(3)

where  $j_m(\cdot)$  and  $P_m(\cdot)$  are the spherical Bessel functions of the first kind and the Legendre polynomials, respectively, both of order *m*. The eigenvalues,  $\lambda_{m,i'}$  decay coefficients,  $\Gamma_{m,i'}$  and time constants,  $\tau_{m,i'}$  are also seen here. The discrete eigenvalues,  $\lambda_{m,i'}$  are generated by transforming the aforementioned boundary condition into the characteristic equation  $j_m(\lambda_{m,i})/j'_m(\lambda_{m,i}) = -D\lambda_{m,i'}/(S_v a)$  and solving this characteristic equation. The decay coefficients,  $\Gamma_{m,i'}$  are found by applying the initial condition of a uniform free-carrier density,  $N_0$ . The time constants,  $\tau_{m,i'}$  are defined by

$$\frac{1}{\tau_{m,i}} = \frac{1}{\tau_{\rm b}} + \frac{D\lambda_{m,i}^{2}}{a^{2}}$$
(4)

For the present study, the nanoparticle is uniformly illuminated, with  $\theta$  independence, and the nanoparticle radius is much less than the diffusion length. Thus, the general solution in eq 3 has a finite term only for m = 0, and the i = 1 term of the remaining expansion dominates over the subsequent terms. This allows eq 3 to be rewritten as

$$N(r, t) \approx \Gamma \frac{\sin(\lambda r/a)}{\lambda r/a} e^{-t/\tau}$$
(5)

where the eigenvalue is  $\lambda = \lambda_{0,1}$ , the decay coefficient is  $\Gamma = \Gamma_{0,1} = 2N_0[\sin(\lambda) - \lambda \cos(\lambda)]/[\lambda - \sin(\lambda) \cos(\lambda)]$ , and the time constant is  $\tau = \tau_{0,1}$ . With these definitions, the characteristic equation can be recast in the simplified form of  $\tan \lambda/\lambda = (1 - Sa/D)^{-1}$ . The transcendental form of the simplified characteristic equation can be accommodated by computing  $\lambda$  with a

numerical routine and applying this eigenvalue in eq 5 to compute the free-carrier density distribution, N(r, t).

It is worth noting that the transcendental form of the simplified characteristic equation can also be accommodated with further approximations. For a nanoparticle radius that is much less than the diffusion length, i.e., a large diffusion coefficient,  $D \gg S_v a$ , the eigenvalue will become small, i.e.,  $\lambda \rightarrow 0$ . This allows the left and right sides of the simplified characteristic equation to be expanded, yielding  $D\lambda^2 \approx 3S_V a$ . With this result, eq 4 can be rewritten as the generalized approximation of

$$\frac{1}{\tau} \approx \frac{1}{\tau_{\rm b}} + S_{\rm v} R \tag{6}$$

where R = 3/a is the surface-to-volume ratio of the sphere. The expression in eq 6 is the form that is often seen and applied in the literature.<sup>32</sup> In this limiting case of small  $\lambda$ , the decay coefficient becomes  $\Gamma \approx N_0$ , the cardinal sine term in eq 5 becomes  $\sin(\lambda r/a)/(\lambda r/a) \approx 1$ , and the free-carrier density distribution simply manifests itself as the average free-carrier density,

$$N(t) \approx N_0 \mathrm{e}^{-t/\tau} \tag{7}$$

The time-domain solutions from eqs 4 and 5 are computed for a variety of parameters and are compared to the frequency-domain solutions from eq 2. It is found that the solutions match within 1% error.

The overall responses for time constants of semiconductor nanoparticles are illustrated in Figure 2. The figure shows the



**Figure 2.** Characterization of time constants for semiconductor nanoparticles. The time constant,  $\tau$ , i.e., switching time, is displayed versus the surface recombination velocity,  $S_{vr}$  and radius, a, for a nanoparticle with rapid diffusion, i.e.,  $D \gg S_v a$ , and a long bulk lifetime, i.e.,  $\tau_b$ . Results are formed by solving eqs 4 and 5. The red region is the desired (subpicosecond) regime. Inset "a" shows the nonuniform free-carrier density distribution, N(r, t = 0.5 ps), in the nanoparticle for a small diffusion coefficient, i.e.,  $D \approx S_v a$ . Inset "b" shows the uniform free-carrier density distribution, N(r, t = 0.5 ps), in the nanoparticle for a large diffusion coefficient, i.e.,  $D \gg S_v a$ .

time constant,  $\tau$ , as a function of the surface recombination velocity,  $S_{v}$ , and radius, *a*, for a nanoparticle having a large diffusion coefficient, i.e.,  $D \gg S_v a$ , and long bulk lifetime, i.e.,  $\tau_{\rm b}$  $\rightarrow \infty$ . It is immediately apparent from this figure that  $\tau$ decreases linearly with both a and  $1/S_{ut}$  which is in agreement with the generalized approximation in eq 5. Such scaling is of importance in the application of these nanoparticles to alloptical switching, as the observed time constants manifest themselves in the AOS implementations. The red region of Figure 2 is demarcated to show the regime for which femtosecond switching times are achieved. From the bounds of this red region, it is concluded that the semiconductor nanoparticle composition should be selected to have a sufficiently high surface recombination velocity, being greater than  $S_v = 2000$  m/s, and the semiconductor nanoparticle size should be selected to have a sufficiently small radius, being less than a = 30 nm. At the same time, the diffusion coefficient of the semiconductor nanoparticle should be sufficiently high, i.e.,  $D \gg S_{\rm v}a$ , to maintain rapid diffusive transport of free carriers from the interior to the surface. If the diffusive transport is impeded by a low diffusion coefficient, i.e.,  $D \approx S_v a$ , the recombination of free carriers witnesses a bottleneck. This lowdiffusion scenario is illustrated in inset "a" of Figure 2, which shows the free-carrier density distribution within the semiconductor nanoparticle as a colormap for  $D \approx S_{a}a$  and a time of 0.5 ps. The colormap is nonuniform because there is a bottleneck of free carriers within the interior of the semiconductor nanoparticle. In contrast, if the diffusion coefficient is high, i.e.,  $D \gg S_v a$ , the diffusive transport is sufficiently rapid to have the recombination of free carriers be readily facilitated by surface states, leading to a relatively uniform free-carrier density distribution within the semiconductor nanoparticle. This high-diffusion scenario is illustrated in inset "b" of Figure 2. The free-carrier density distribution within the semiconductor nanoparticle, for  $D \gg S_v a$  and a time of 0.5 ps, is seen to be a uniform colormap. In general, it is advantageous to have the diffusion coefficient be as large as possible for rapid diffusive transport.

The proposed AOS, integrating the photonic nanojet with semiconductor nanoparticles, is tested with a series of experiments. The applied microspheres are made of N-LASF9 glass having a diameter of  $d = 40 \ \mu m$  and refractive index of n = 1.83. The semiconductor nanoparticles are embedded onto the surface of the microsphere with a dry-coating process.<sup>33</sup> Van der Waals forces in this process provide sufficient adhesion.

The type of semiconductor used for the semiconductor nanoparticles is constrained by the control and signal beams' wavelengths. The signal beam's wavelength is chosen to be at the telecommunications wavelength of 1550 nm (0.8 eV) for practical integration, low propagation losses, and increased sensitivity to free-carrier dispersion (which scales with the wavelength-squared).<sup>30</sup> The control beam is generated at a wavelength of 775 nm (1.6 eV), by second-harmonic conversion of the signal beam. On the basis of these two wavelengths, the semiconductor band gap must fall in the range 0.8–1.6 eV. Si (having a 1.11 eV indirect band gap), CdTe (having a 1.56 eV direct band gap), InP (having a 1.27 eV direct band gap), and p-type CuO (having a 1.21 eV indirect band gap)<sup>34</sup> are selected, as their band gaps are within the desired range.

The investigations are carried out with a 775–1550 nm pump–probe experimental setup to characterize the impulse response of the AOS. An erbium-doped fiber laser (Toptica



**Figure 3.** Characterization of the AOS for microspheres with a diameter of  $d = 40 \ \mu\text{m}$  and refractive index of n = 1.83, with select nanoparticle coatings. Normalized differential transmission of the signal beam,  $\Delta T/T$ , is shown versus time for (a) Si, (b) CdTe, (c) InP, and (d) CuO nanoparticles. The results exhibit minimum switching energies of 1 pJ, 500 fJ, 400 fJ, and 300 fJ, with switching times of 2 ps, 2.3 ps, 900 fs, and 350 fs, respectively. Insets show Lorenz–Mie theory simulations with logarithmic intensities and SEM images of nanoparticles, with a 200 nm scale bar.

Photonics, Inc.) with a 100 fs pulse duration and 90 MHz repetition rate is used. The differential transmission,  $\Delta T(t)/T$ , of the signal beam is measured as a function of the time delay of the control (pump) and signal (probe) pulses, using a lock-in amplifier (Stanford Research Systems, SR830) with a 100 ms time constant.

Representative all-optical switching results for each semiconductor are shown in Figure 3, as measurements of the differential signal beam's transmission,  $\Delta T(t)/T$ . The results for the Si, CdTe, InP, and CuO nanoparticles are given in Figure 3a-d, respectively. The minimum switching energies, defined for a signal-to-noise ratio of 1, are estimated based on the relative strength of each waveform, while the signal and control beam powers are held constant. The switching time (or time constant) is measured via curve fitting from each  $\Delta T(t)/T$ waveform.

Si nanoparticles, shown in the inset of Figure 3a, have an average radius of 40 nm. The nanoparticles yield a switching energy of 1 pJ and switching time of 1.8 ps. The large (picojoule) switching energy is attributed to the indirect band gap of Si and the resulting poor quantum efficiency. The long (picosecond) switching time is attributed to the large radius of the Si nanoparticles. The applied free-carrier dynamical model suggests that the Si nanoparticles have a surface recombination velocity of 7400 ms<sup>-1</sup>. Note that Si nanoparticles would support the desired femtosecond operation, in the red region of

Figure 2, given a smaller radius, but such changes would not address the unacceptably high switching energy.

CdTe nanoparticles, shown in the inset of Figure 3b, have an average radius of 30 nm. The nanoparticles yield a switching energy of 500 fJ and switching time of 2.3 ps. The femtojoule switching energy seen here is lower than that of Si, which is attributed to the direct band gap of CdTe and the correspondingly high quantum efficiency. The picosecond switching time for CdTe is slower than that of Si, however, which implies that the CdTe surface recombination velocity is lower than that of Si. The applied free-carrier dynamical model suggests that the CdTe nanoparticles have a surface recombination velocity of 4300 ms<sup>-1</sup>. With this surface recombination velocity, the radius could be reduced to enable the desired femtosecond operation in the red region of Figure 2. However, the radius would need to be reduced below 13 nm, and this would encroach upon CdTe's Bohr radius of 7.3 nm. The resulting quantum confinement would likely increase the band gap beyond the 1.6 eV photon energy of the control beam.

InP nanoparticles, shown in the inset of Figure 3c, have an average radius of 20 nm. The nanoparticles yield a switching energy of 400 fJ and switching time of 900 fs. The femtojoule switching energy seen here for InP is attributed to its direct band gap. At the same time, the femtosecond switching time seen here is the result of its high surface recombination velocity. The applied free-carrier dynamical model suggests that the InP

nanoparticles have a surface recombination velocity of 7400  $ms^{-1}$ . This value, along with the radius, does establish operation in the red region of Figure 2. Thus, InP nanoparticles can meet the concurrent demands for femtojoule switching energies and femtosecond switching times.

CuO nanoparticles, shown in the inset of Figure 3d, have an average radius of 20 nm. The nanoparticles yield a switching energy of 300 fJ and switching time of 350 fs. The switching energy seen here is especially low. The switching time is the fastest seen, but it is important to note that the recovery exhibits two distinct time constants. We propose that the two time constants are the result of free-carrier recombination, which evolves according to the above analyses, as well as freecarrier relaxation, which is seen through state filling. The CuO nanoparticles have a p-type lattice and numerous midgap surface states that can act as traps. For such a system, the signal beam undergoes absorption from valence band states to midgap states, while the control beam undergoes absorption from valence band states to conduction band states. Thus, the arrival of the control beam depletes the electron occupancy in the valence band, i.e., increases the hole occupancy, which leads to state-filling effects on the signal beam. The signal beam responds with a rapid increase in transmission then a rapid decrease in transmission over the 350 fs time constant as holes relax throughout the valence band states. The 350 fs time constant seen for these CuO nanoparticles is in good agreement with the 400 fs time constant recently measured for relaxation in the valence band of CuO nanowires.<sup>28</sup> The relaxed free carriers then undergo trap-assisted recombination,<sup>36</sup> which is seen as a weaker (8%) decay over a time constant of 2.0 ps. (The two time constants were curve fit to be within an R-squared of 0.9997.) Given that the CuO response is dominated by the femtosecond contributions of state filling, CuO nanoparticles can meet the concurrent demands for femtojoule switching energies and femtosecond switching times.

The authors note that the semiconductor nanoparticles employed in this investigation have sufficiently high standard deviations to allow for testing of nanoparticles with varying sizes. The results presented above for Si, CdTe, and InP were chosen to have the smallest particles and the shortest time constants. It is interesting to note, however, that the 350 fs time constant of the CuO nanoparticles was largely independent of the particle size, which supports the interpretation of the predominance of free-carrier relaxation seen via state filling. In addition, the surface combination velocities quoted here are marginally higher than those seen in the literature.<sup>18,37,38</sup> We attribute this distinction to the high curvature of the nanoparticles, which leads to pronounced lattice defects and hastened surface recombination, compared to surfaces on a more macroscopic scale.

In conclusion, this study investigated the integration of subdiffractional photonic nanojets with semiconductor nanoparticles of select compositions for application to all-optical switching. The characteristics of femtojoule switching energies and femtosecond switching times were pursued. For operation with low switching energies, a nanophotonic superlens was applied in the form of a dielectric microsphere. The appropriately designed dielectric microsphere was found to establish a photonic nanojet at its rear surface with an especially high intensity. This yielded enhanced interaction between the control and signal beams. Optimal characteristics were defined by Lorenz–Mie theory simulations, leading to the selection of an N-LASF9 glass microsphere with a diameter of  $d = 40 \ \mu m$ and refractive index of n = 1.83. For operation with short switching times, semiconductor nanoparticles were applied on the microsphere's rear surface. The semiconductor nanoparticles comprised Si, CdTe, InP, and CuO. It was found that the increased presence of surface states within the semiconductor nanoparticles led to hastened surface recombination and rapid recovery. A free-carrier dynamical model was developed to reveal a deeper understanding (and exploitation) of this recovery. The AOS, employing photonic nanojets with Si, CdTe, InP, and CuO nanoparticles, was tested. It was found to have minimum switching energies, estimated to be 1 pJ, 500 fJ, 400 fJ, and 300 fJ, and switching times of 2 ps, 2.3 ps, 900 fs, and 350 fs, respectively. The optimal semiconductor witnessed in this study was CuO, which readily achieved the goals of femtojoule switching energies and femtosecond switching times.

The authors also note that the proposed AOS can meet the performance demands of emerging optical fiber front-end operations, such as optical multiplexing.<sup>3,5</sup> At the same time, from a practical standpoint, the monolithic architecture of the AOS, with a compact device footprint and an integrated focusing element, allows for ease of coupling and omnidirectional operation. Such an architecture can be readily applied in cascaded on-chip implementations, through daisy-chained spheres,<sup>39</sup> which have proven to be challenging<sup>40</sup> for AOS devices. Future work could improve upon the AOS by tuning the nanoparticles for Mie resonance to increase the modulation depth.<sup>41,42</sup> Overall, the proposed AOS can become a fundamental element in future all-optical implementations.

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